Spring-loaded test probe GKS-040 207 040 A 0800 Item GKS-040-0041





- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles

General data

Product group	ICT / FCT (in-circuit test and function test
Sub-product group	Standard stroke test probe
Series	GKS-040
Grid	1 mm [40 mil]
Contacting from	Pad, via
Magnetic	Yes
Installation type	Plug-in
Quick-exchange system	Yes
Adjustable installation h	neight No
Non-rotating	No
Compatible receptacle(s	s) KS-040
Min. temperature	- 40 °C [- 104 °F]
Max. temperature	+ 80 °C [+ 176 °F]
RoHS-compliant	RoHS-3;6a

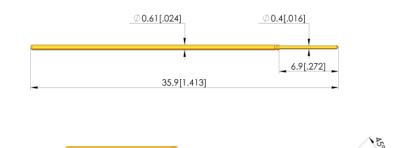


Electrical data

Current load capacity / rated current 2 A Typical resistance (Ri) <20 mOhm

Mechanical data

Total length	35.9 mm [1.41 in]
Barrel diameter	0.61 mm [.024 in]
Maximum stroke	6.35 mm [.25 in]
Spring pre-load	0.15 N [.539 ozf]
Collar height	00
Spring force at working stroke	0.8 N [2.87 ozf]
Recommended working stroke	4.3 mm [.169 in]



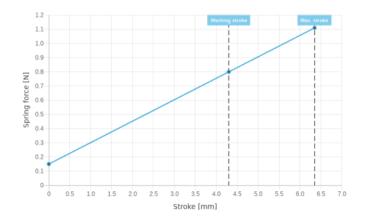
Tip style data

rip style	u / 90° 3-eagea chisei, seit-cleaning
Tip diameter	0.4 mm [.015 in]
Tip style surface	A gold
Tip style material	2 stee

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INGUN Prüfmittelbau GmbH

Max-Stromeyer-Straße 162 78467, Constance, Germany Phone +49 7531 8105-0 Customer hotline +49 7531 8105-888 Fax +49 7531 8105-65 info@ingun.com













Learn more about ICT/FCT Test probes

